



#### N-CHANNEL ENHANCEMENT MODE MOSFET

#### **Product Summary**

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> max	I <sub>D</sub> max T <sub>A</sub> = 25°C
20V	$55m\Omega @ V_{GS} = 4.5V$	4.0A
	70mΩ @ V <sub>GS</sub> = 2.5V	3.5A
	$90m\Omega @ V_{GS} = 1.8V$	3.1A
	130mΩ @ V <sub>GS</sub> = 1.5V	2.5A

### **Description and Applications**

This new generation MOSFET has been designed to minimize the onstate resistance ( $R_{DS(on)}$ ) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- General Purpose Interfacing Switch
- Power Management Functions

### **Features and Benefits**

- Low On-Resistance
- Low Gate Threshold Voltage
- Low Input Capacitance
- Fast Switching Speed
- ESD Protected Gate
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

#### **Mechanical Data**

- Case: SOT26
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Matte Tin annealed over Copper leadframe.
   Solderable per MIL-STD-202, Method 208

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• Weight: 0.015 grams (approximate)





Top View

SOT26

Top View
Internal Schematic

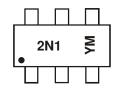
#### **Ordering Information** (Note 4)

Part Number	Case	Packaging	
DMN2100UDM-7	SOT26	3000/Tape & Reel	

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com...

## **Marking Information**



2N1 = Marking Code YM = Date Code Marking Y = Year (ex: U = 2007) M = Month (ex: 9 = September)

Date Code Key

Year	2007	2008	2009	2010	201	1 20	12	2013	3 2	2014	2015	2016	2017
Code	U	V	W	Х	Υ		Z	Α		В	С	D	Е
Month	Jan	Feb	Mar	Apr	May	Jun	Ju	ı	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7		8	9	0	N	D



### Maximum Ratings @TA = 25°C unless otherwise specified

Characteristic	Symbol	Value	Units			
Drain-Source Voltage	$V_{DSS}$	20	V			
Gate-Source Voltage	$V_{GSS}$	±8	V			
Continuous Drain Courset (Note C) V	Steady State	$T_A = 25$ °C $T_A = 70$ °C	I <sub>D</sub>	4.0 3.1	Α	
Continuous Drain Current (Note 6) V <sub>GS</sub> = 4.5V	t<10s	$T_A = 25$ °C $T_A = 70$ °C	I <sub>D</sub>	4.5 3.5	А	
Pulsed Drain Current (10µs pulse, duty cycle = 1%)	I <sub>DM</sub>	13	Α			
Maximum Body Diode Continuous Current	Is	1.5	Α			

## **Thermal Characteristics** @T<sub>A</sub> = 25°C unless otherwise specified

Characteristic		Symbol	Value	Units	
Total Power Dissipation (Note 5)	T <sub>A</sub> = 25°C	Б	1	W	
Total Power Dissipation (Note 5)	T <sub>A</sub> = 70°C	$P_{D}$	0.6	VV	
Thermal Resistance, Junction to Ambient (Note 5)	Steady state	Б	127	°C/W	
memial nesistance, buildion to Ambient (Note 3)	t<10s	$R_{\theta JA}$	91		
Total Dower Dissination (Note 6)	T <sub>A</sub> = 25°C	Б	1.5	W	
Total Power Dissipation (Note 6)	$T_A = 70$ °C	$P_D$	0.9		
Thermal Begintance, Junation to Ambient (Note 6)	Steady state	Ъ	85	°C/W	
Thermal Resistance, Junction to Ambient (Note 6)	t<10s	$R_{\theta JA}$	63		
Thermal Resistance, Junction to Case (Note 6)	$R_{\theta JC}$	3.1			
Operating and Storage Temperature Range		T <sub>J,</sub> T <sub>STG</sub>	-55 to +150	°C	

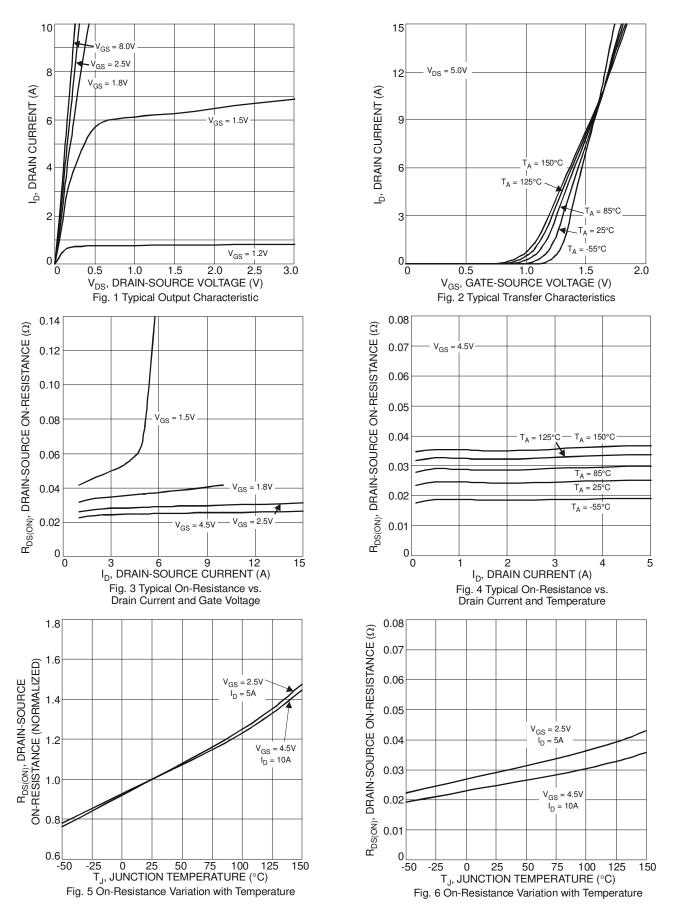
# Electrical Characteristics @TA = 25°C unless otherwise specified

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	20	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	1	μΑ	$V_{DS} = 20V, V_{GS} = 0V$
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±1	μΑ	$V_{GS} = \pm 8V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	V <sub>GS(th)</sub>	0.6	_	1.0	V	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$
		_	32	55		$V_{GS} = 4.5V, I_D = 6A$
Static Drain-Source On-Resistance		_	43	70		$V_{GS} = 2.5V, I_D = 4.0A$
Static Drain-Source On-Resistance	R <sub>DS</sub> (ON)	_	56	90	mΩ	$V_{GS} = 1.8V, I_D = 1.5A$
		_	80	130		$V_{GS} = 1.5V, I_D = 1.0A$
Forward Transfer Admittance	Y <sub>fs</sub>	_	8	_	S	V <sub>DS</sub> =10V, I <sub>D</sub> = 6A
Diode Forward Voltage	V <sub>SD</sub>	_	0.7	1.1	V	$V_{GS} = 0V, I_{S} = 2A$
DYNAMIC CHARACTERISTICS (Note 8)						
Input Capacitance	C <sub>iss</sub>	_	555	_	pF	V 40V V 0V
Output Capacitance	Coss	_	112	_	pF	V <sub>DS</sub> = 10V, V <sub>GS</sub> = 0V -f = 1.0MHz
Reverse Transfer Capacitance	C <sub>rss</sub>	_	84	_	pF	T = T.UIVIHZ
Total Gate Charge	Qg	_	8.8	_	nC	V 40V V 45V
Gate-Source Charge	Q <sub>gs</sub>	_	1.4	_	nC	$V_{DS} = 10V, V_{GS} = 4.5V,$
Gate-Drain Charge	Q <sub>gd</sub>	_	3	_	nC	$I_D = 6.5A$
Turn-On Delay Time	t <sub>D(on)</sub>	_	53	_	ns	
Turn-On Rise Time		_	78	_	ns	$V_{DS} = 10V, I_D = 1.0A$
Turn-Off Delay Time	t <sub>D(off)</sub>	_	561	_	ns	$V_{GS} = 4.5V$ , $R_G = 6\Omega$
Turn-Off Fall Time		_	234	_	ns	

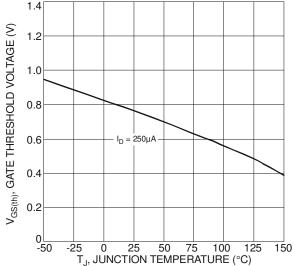
Notes:

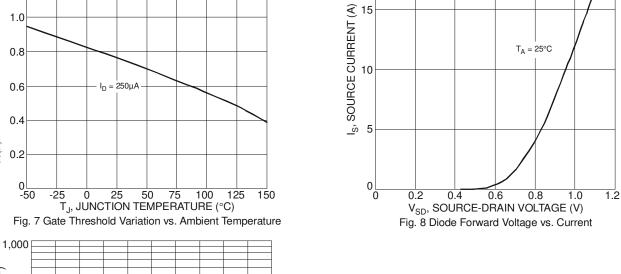
- Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.
   Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate
   Short duration pulse test used to minimize self-heating effect
   Guaranteed by design. Not subject to production testing



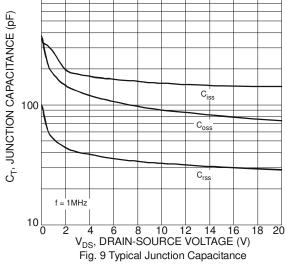


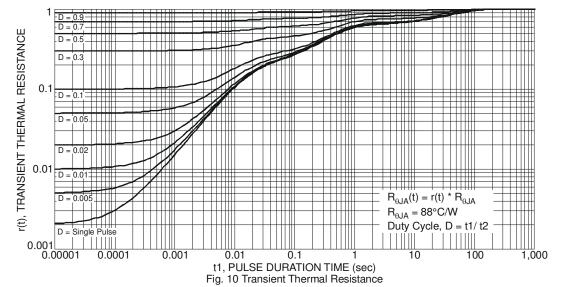






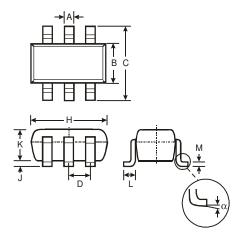
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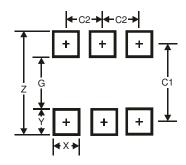


# **Package Outline Dimensions**



	SOT26							
Dim	Min	Max	Тур					
Α	0.35	0.50	0.38					
В	1.50	1.70	1.60					
С	2.70	3.00	2.80					
D	_		0.95					
Н	2.90	3.10	3.00					
J	0.013	0.10	0.05					
K	1.00	1.30	1.10					
L	0.35	0.55	0.40					
М	0.10	0.20	0.15					
α	0°	8°	_					
All Dimensions in mm								

# **Suggested Pad Layout**



Dimensions	Value (in mm)
Z	3.20
G	1.60
Х	0.55
Υ	0.80
C1	2.40
C2	0.95



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